

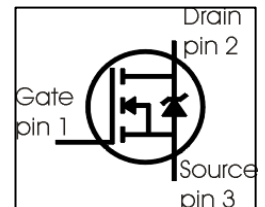
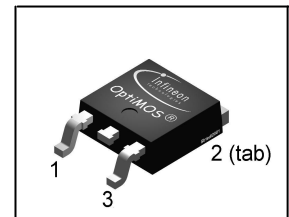
**OptiMOS® Power-Transistor**
**Feature**

- N-Channel
- Enhancement mode
- Excellent Gate Charge x  $R_{DS(on)}$  product (FOM)
- Superior thermal resistance
- 175°C operating temperature
- Avalanche rated
- $dv/dt$  rated

**Product Summary**

$V_{DS}$	30	V
$R_{DS(on)}$	7.3	mΩ
$I_D$	50	A

P- TO252 -3-11



Type	Package	Ordering Code	Marking
SPD50N03S2-07	P- TO252 -3-11	Q67040-S4430	PN0307

**Maximum Ratings**, at  $T_j = 25\text{ °C}$ , unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current <sup>1)</sup> $T_C=25\text{ °C}$	$I_D$	50 50	A
Pulsed drain current $T_C=25\text{ °C}$	$I_{D\text{ puls}}$	200	
Avalanche energy, single pulse $I_D=50\text{ A}$ , $V_{DD}=25\text{ V}$ , $R_{GS}=25\text{ Ω}$	$E_{AS}$	250	mJ
Repetitive avalanche energy, limited by $T_{jmax}^{2)}$	$E_{AR}$	13	
Reverse diode $dV/dt$ $I_S=50\text{ A}$ , $V_{DS}=24\text{ V}$ , $dI/dt=200\text{ A/μs}$ , $T_{jmax}=175\text{ °C}$	$dV/dt$	6	kV/μs
Gate source voltage	$V_{GS}$	±20	V
Power dissipation $T_C=25\text{ °C}$	$P_{tot}$	136	W
Operating and storage temperature	$T_j$ , $T_{stg}$	-55... +175	°C
IEC climatic category; DIN IEC 68-1		55/175/56	

**Thermal Characteristics**

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - case	$R_{thJC}$	-	0.7	1.1	K/W
Thermal resistance, junction - ambient, leaded	$R_{thJA}$	-	-	100	
SMD version, device on PCB:	$R_{thJA}$				
@ min. footprint		-	-	75	
@ 6 cm <sup>2</sup> cooling area <sup>3)</sup>		-	-	50	

**Electrical Characteristics, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified**

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain-source breakdown voltage $V_{GS}=0V, I_D=1mA$	$V_{(BR)DSS}$	30	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D=85\mu A$	$V_{GS(th)}$	2.1	3	4	
Zero gate voltage drain current $V_{DS}=30V, V_{GS}=0V, T_j=25^{\circ}C$ $V_{DS}=30V, V_{GS}=0V, T_j=125^{\circ}C$	$I_{DSS}$	- -	0.01 1	1 100	$\mu A$
Gate-source leakage current $V_{GS}=20V, V_{DS}=0V$	$I_{GSS}$	-	1	100	
Drain-source on-state resistance $V_{GS}=10V, I_D=50A$	$R_{DS(on)}$	-	5.7	7.3	$m\Omega$

<sup>1</sup>Current limited by bondwire ; with an  $R_{thJC} = 1.1K/W$  the chip is able to carry  $I_D = 106A$  at  $25^\circ\text{C}$ , for detailed information see app.-note ANPS071E available at [www.infineon.com/optimos](http://www.infineon.com/optimos)

<sup>2</sup>Defined by design. Not subject to production test.

<sup>3</sup>Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70  $\mu m$  thick) copper area for drain connection. PCB is vertical without blown air.

**Electrical Characteristics**

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Dynamic Characteristics**

Transconductance	$g_{fs}$	$V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ , $I_D = 50A$	30	60	-	S
Input capacitance	$C_{iss}$	$V_{GS} = 0V$ , $V_{DS} = 25V$ , $f = 1MHz$	-	1630	2170	pF
Output capacitance	$C_{oss}$		-	750	1000	
Reverse transfer capacitance	$C_{rss}$		-	150	230	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 15V$ , $V_{GS} = 10V$ , $I_D = 50A$ , $R_G = 6.8\Omega$	-	14	21	ns
Rise time	$t_r$		-	36	54	
Turn-off delay time	$t_{d(off)}$		-	27	40	
Fall time	$t_f$		-	25	38	

**Gate Charge Characteristics**

Gate to source charge	$Q_{gs}$	$V_{DD} = 24V$ , $I_D = 50A$	-	7.9	10.5	nC
Gate to drain charge	$Q_{gd}$		-	14.1	21.1	
Gate charge total	$Q_g$	$V_{DD} = 24V$ , $I_D = 50A$ , $V_{GS} = 0$ to $10V$	-	35	46.5	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = 24V$ , $I_D = 50A$	-	5.2	-	V

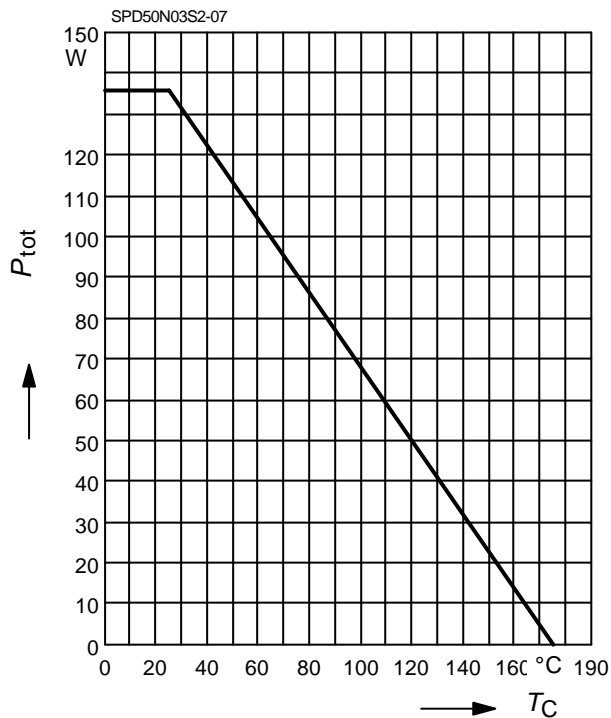
**Reverse Diode**

Inverse diode continuous forward current	$I_S$	$T_C = 25^\circ C$	-	-	50	A
Inv. diode direct current, pulsed	$I_{SM}$		-	-	200	
Inverse diode forward voltage	$V_{SD}$	$V_{GS} = 0V$ , $I_F = 50A$	-	0.9	1.3	V
Reverse recovery time	$t_{rr}$	$V_R = 15V$ , $I_F = I_S$ , $di_F/dt = 100A/\mu s$	-	41	51	ns
Reverse recovery charge	$Q_{rr}$		-	46	58	nC

### 1 Power dissipation

$$P_{\text{tot}} = f(T_C)$$

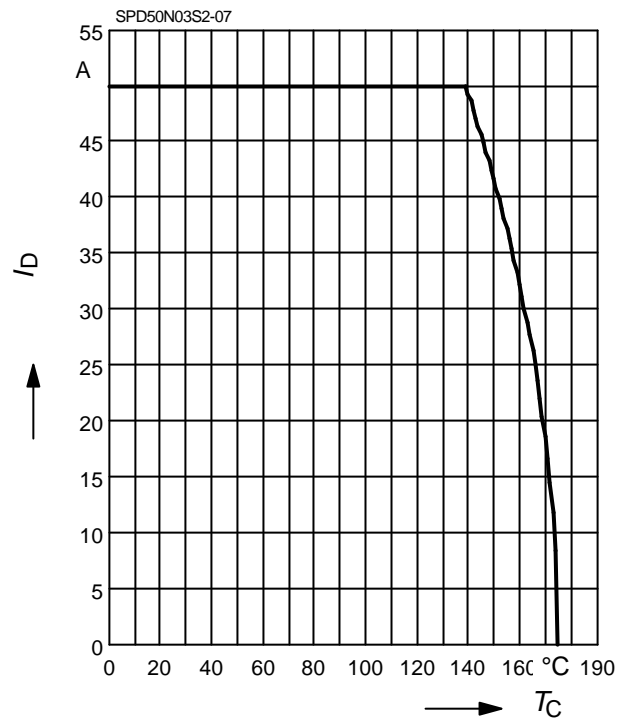
parameter:  $V_{GS} \geq 6 \text{ V}$



### 2 Drain current

$$I_D = f(T_C)$$

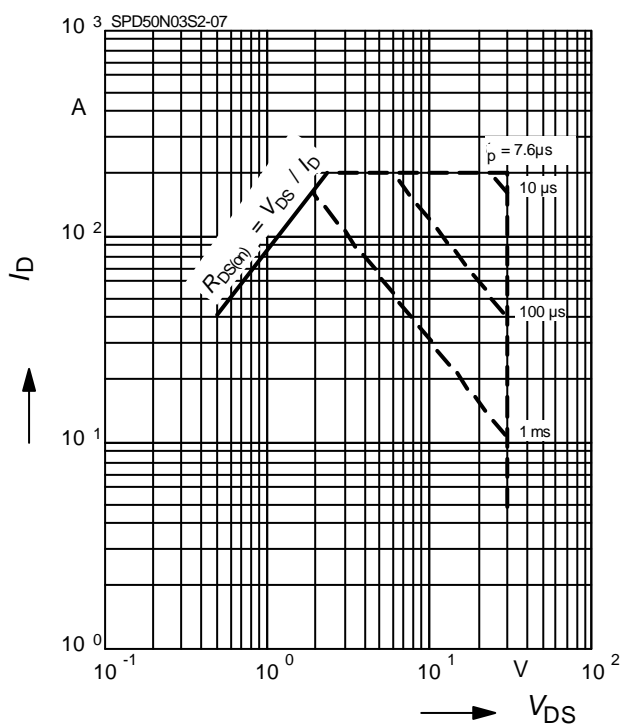
parameter:  $V_{GS} \geq 10 \text{ V}$



### 3 Safe operating area

$$I_D = f(V_{DS})$$

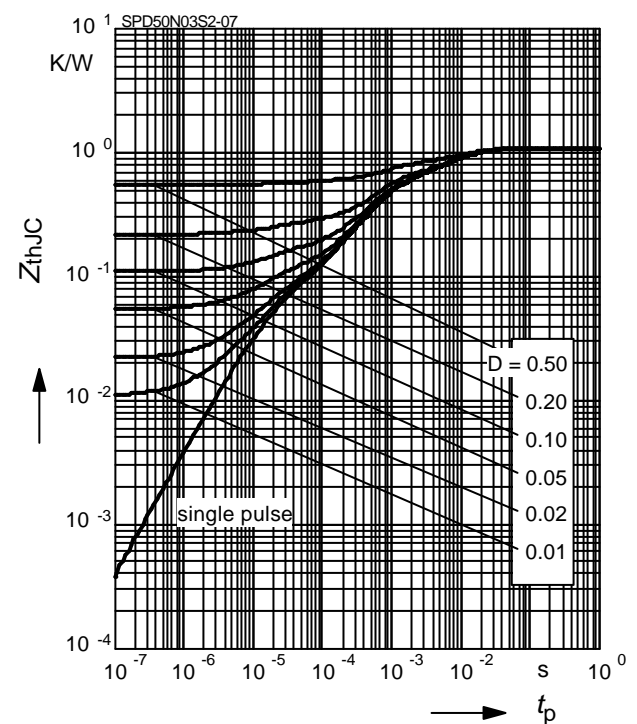
parameter:  $D = 0$ ,  $T_C = 25 \text{ °C}$



### 4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

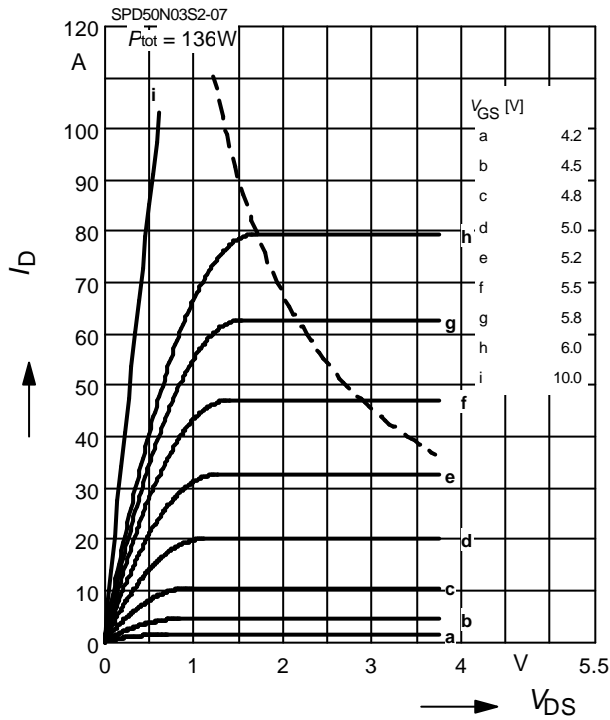
parameter:  $D = t_p/T$



**5 Typ. output characteristic**

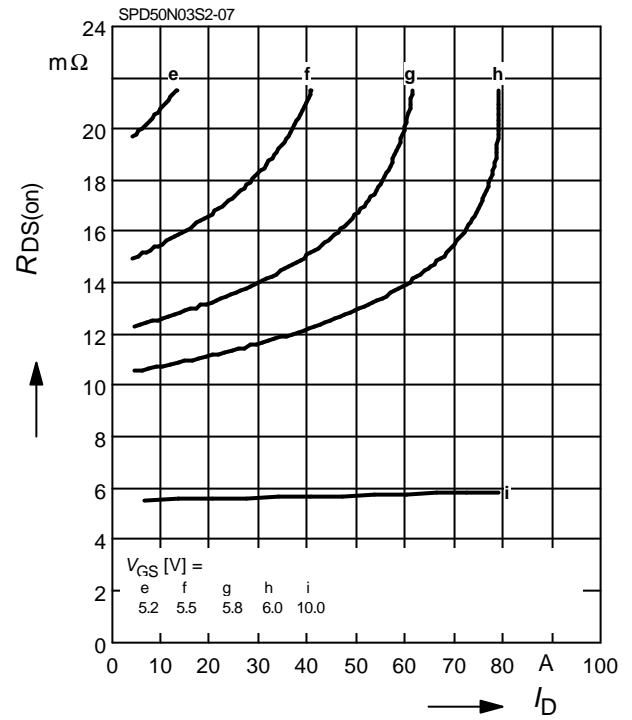
$$I_D = f(V_{DS}); T_J = 25^\circ\text{C}$$

parameter:  $t_p = 80 \mu\text{s}$


**6 Typ. drain-source on resistance**

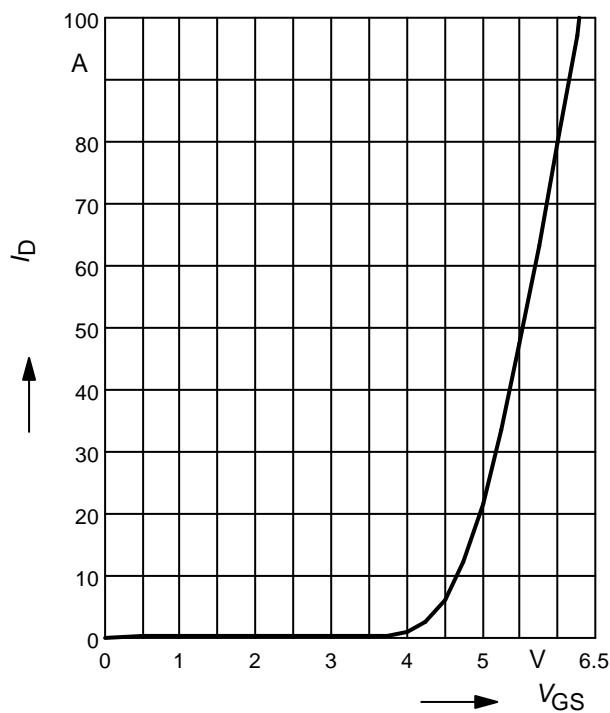
$$R_{DS(on)} = f(I_D)$$

parameter:  $V_{GS}$


**7 Typ. transfer characteristics**

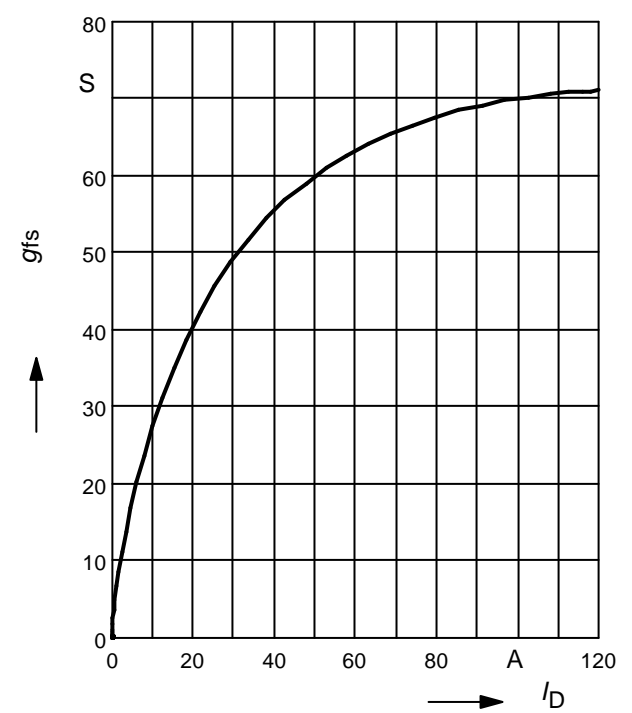
$$I_D = f(V_{GS}); V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$$

parameter:  $t_p = 80 \mu\text{s}$


**8 Typ. forward transconductance**

$$g_{fs} = f(I_D); T_J = 25^\circ\text{C}$$

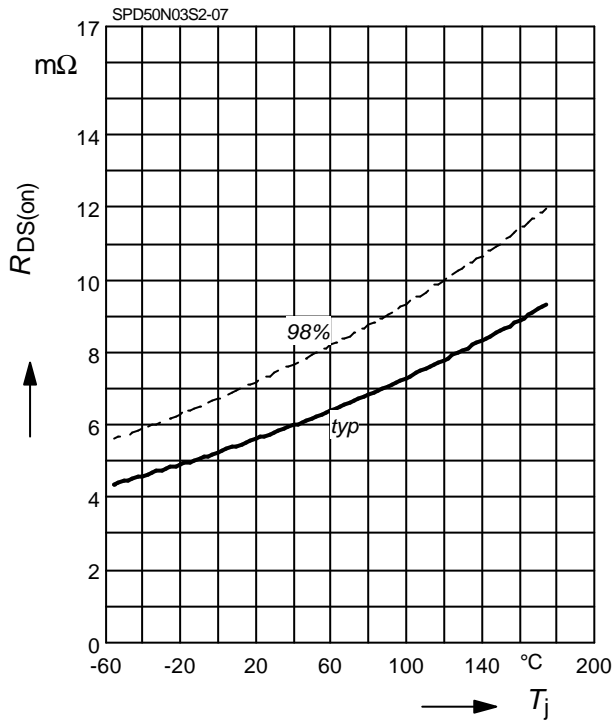
parameter:  $g_{fs}$



### 9 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

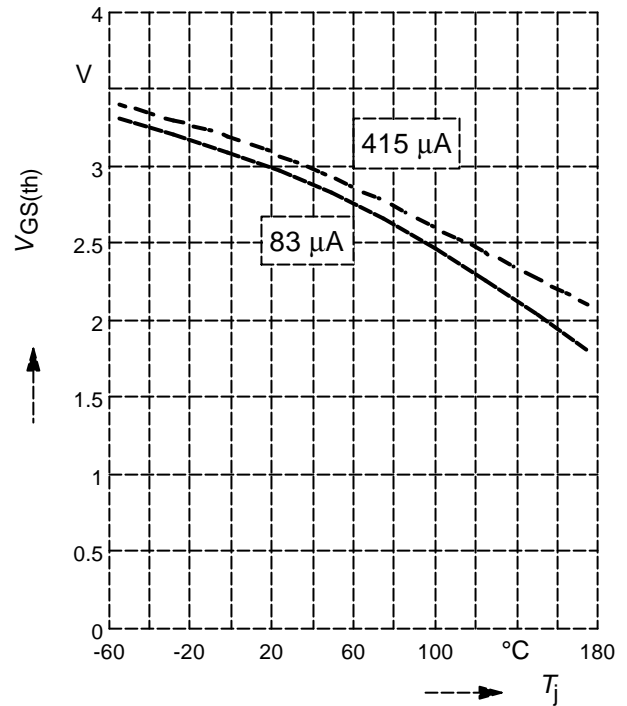
parameter:  $I_D = 50\text{ A}$ ,  $V_{GS} = 10\text{ V}$



### 10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

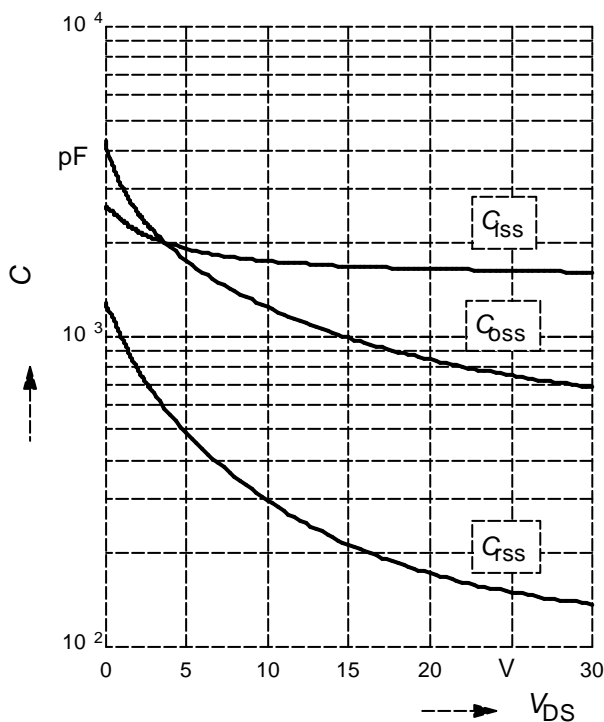
parameter:  $V_{GS} = V_{DS}$



### 11 Typ. capacitances

$$C = f(V_{DS})$$

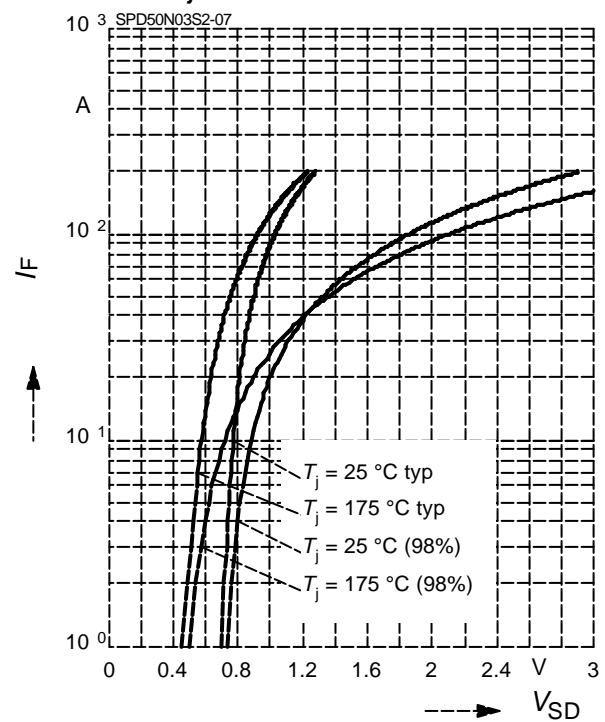
parameter:  $V_{GS} = 0\text{ V}$ ,  $f = 1\text{ MHz}$



### 12 Forward character. of reverse diode

$$I_F = f(V_{SD})$$

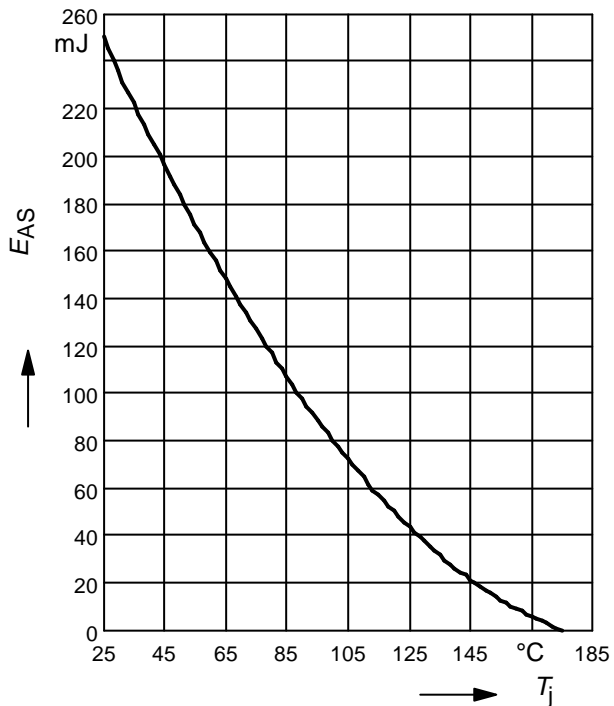
parameter:  $T_j$ ,  $t_p = 80\text{ μs}$



**13 Typ. avalanche energy**

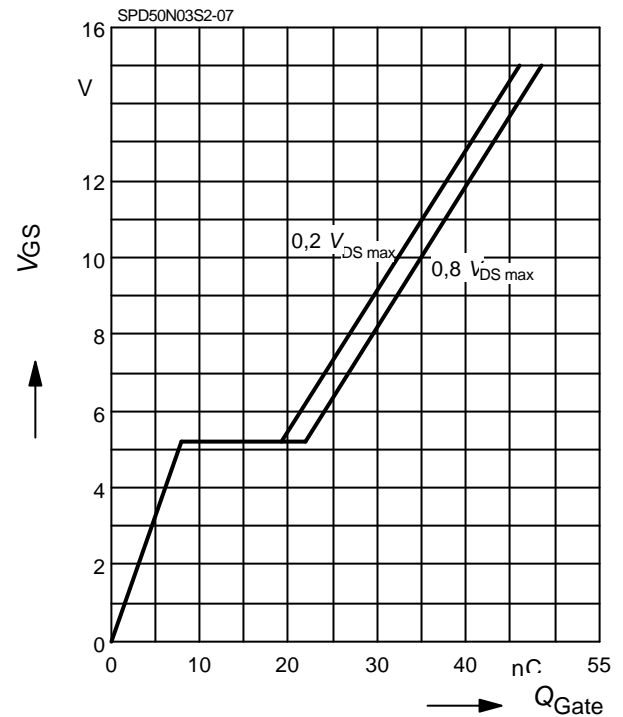
$$E_{AS} = f(T_j)$$

par.:  $I_D = 50\text{ A}$ ,  $V_{DD} = 25\text{ V}$ ,  $R_{GS} = 25\ \Omega$


**14 Typ. gate charge**

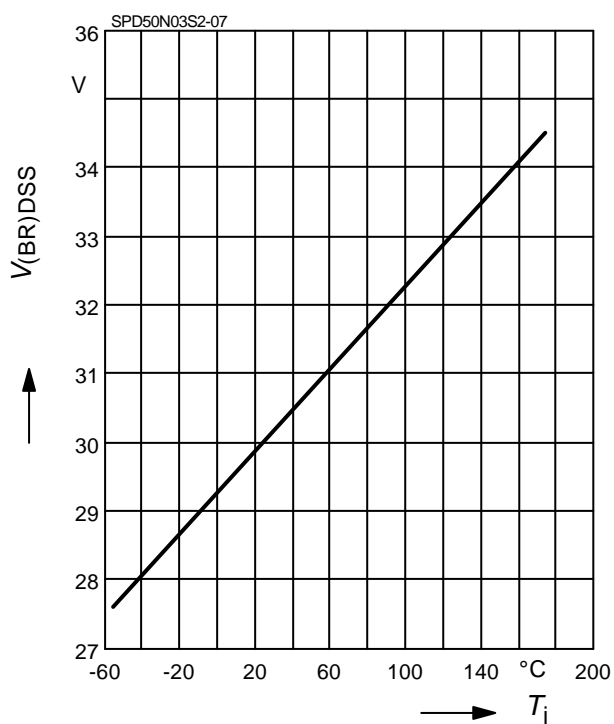
$$V_{GS} = f(Q_{Gate})$$

parameter:  $I_D = 50\text{ A}$  pulsed


**15 Drain-source breakdown voltage**

$$V_{(BR)DSS} = f(T_j)$$

parameter:  $I_D = 10\text{ mA}$



**Published by**  
**Infineon Technologies AG,**  
**Bereichs Kommunikation**  
**St.-Martin-Strasse 53,**  
**D-81541 München**  
**© Infineon Technologies AG 1999**  
**All Rights Reserved.**

**Attention please!**

The information herein is given to describe certain components and shall not be considered as warranted characteristics.

Terms of delivery and rights to technical change reserved.

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

Infineon Technologies is an approved CECC manufacturer.

**Information**

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office in Germany or our Infineon Technologies Representatives worldwide (see address list).

**Warnings**

Due to technical requirements components may contain dangerous substances.

For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies Components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

**Further information**

Please notice that the part number is BSPD50N03S2-07, for simplicity the device is referred to by the term SPD50N03S2-07 throughout this documentation.